

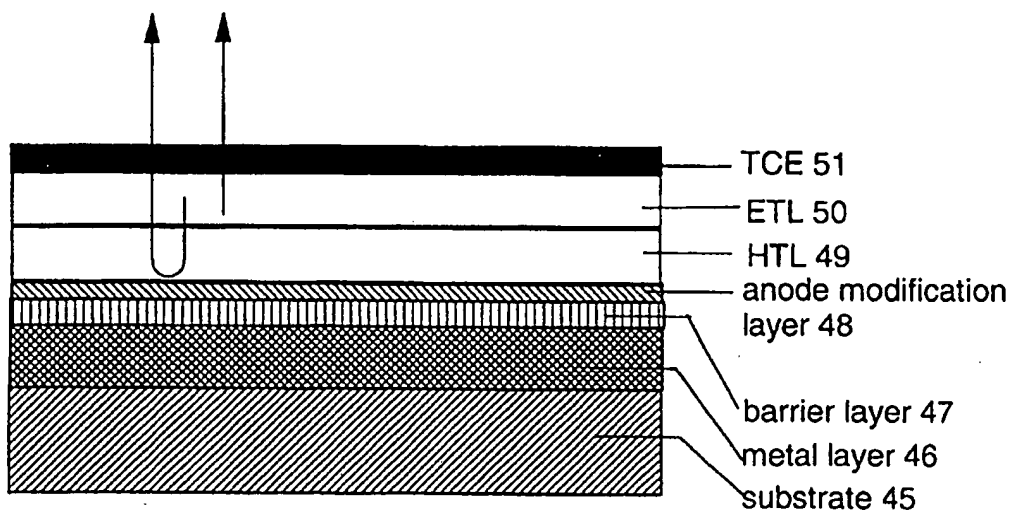


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(54) Title: ANODE MODIFICATION FOR ORGANIC LIGHT EMITTING DIODES

Electroluminescence 52



(57) Abstract

An organic light emitting device is provided which comprises a cathode (51), an anode (48, 47, 46), and an organic region (50, 49) in which electroluminescence takes place if a voltage is applied between said anode and cathode. The anode comprises a metal layer (46), a barrier layer (47), and an anode modification layer (48). Light is emitted through the cathode (51).

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ANODE MODIFICATION FOR ORGANIC LIGHT EMITTING DIODES

TECHNICAL FIELD

- 5 The present invention pertains to organic electroluminescent displays and methods for making the same.

BACKGROUND OF THE INVENTION

- Organic electroluminescence (EL) has been studied extensively because of its possible applications in discrete light emitting diodes (LED), arrays and displays. Organic materials can
10 potentially replace semiconductors in many LED applications and enable wholly new applications. The ease of organic LED (OLED) fabrication and the continuing development of improved organic materials promise novel and inexpensive OLED display possibilities.

- Organic EL at low efficiency was reported many years ago in e.g. Helfrich et al., Physical
15 Review Letters, Vol. 14, No. 7, 1965, pp. 229-231. Recent developments have been spurred by two reports of efficient organic EL: C.W. Tang et al., Applied Physics Letters, Vol. 51, No. 12, 1987, pp. 913-915, and Burroughes et al., Nature, Vol. 347, 1990, pp. 539. Tang used vacuum deposition of molecular compounds to form OLEDs with two organic layers. Burroughes spin coated a polymer, poly(p-phenylenevinylene), to form a single-organic-layer
20 OLED. The advances described by Tang and in subsequent work by N. Greenham et al., Nature, Vol. 365, 1993, pp. 628-630, were achieved mainly through improvements in OLED design derived from the selection of appropriate organic multilayers and electrode metals.

- The simplest possible OLED structure, depicted in Figure 1A, consists of an organic emission
25 layer 10 sandwiched between cathode 11 and anode 12 electrodes which inject electrons (e^-) and holes (h^+), respectively, which meet in the emission layer 10 and recombine producing light. It has been shown (D. D. C. Bradley, Synthetic Metals, Vol. 54, 1993, pp. 401-405, J.

Peng et al., Japanese Journal of Applied Physics, Vol. 35, No. 3A, 1996, pp. L317-L319, and I. D. Parker, Journal of Applied Physics, Vol. 75, No. 3, 1994, pp. 1656-1666) that improved performance is achieved if the electrode work functions match the respective molecular orbitals (MO) of the organic layer 10. Such an improved structure is shown in Figure 1B where
5 optimized electrode materials 13 and 14 reduce the energy barriers to carrier injection into the organic layer 10. Still, single organic layer structures perform poorly because electrons can traverse the organic layer 10 reaching the anode 14, or holes may reach the cathode 13, in either case resulting in current without light, and lower OLED efficiency.

10 Balanced charge injection is also important. For example, an excellent anode is of limited use if the cathode has a large energy barrier to electron injection. Figure 2 illustrates a device with a large electron barrier 16 such that few electrons are injected, leaving the holes no option but to recombine non-radiatively in or near the cathode 15. The anode and cathode materials should
15 be evenly matched to their respective MOs to provide balanced charge injection and optimized OLED efficiency.

An improved structure in which the electron and hole transport functions are divided between separate organic layers, an electron transport layer 20 (ETL) and a hole transport layer (HTL) 21, is shown in Figure 3. In C.W. Tang et al., Journal of Applied Physics, Vol. 65, No. 9,
20 1989, pp. 3610-3616, it is described that higher carrier mobility is achieved in a two organic layer OLED design, and this led to reduced OLED series resistance enabling equal light output at lower operating voltage. The electrodes 22, 23 can be chosen individually to match to the ETL 20 and HTL 21 MOs, respectively, while recombination occurs at the interface 24 of organic layers 20 and 21, far from either electrode. As electrodes, Tang used a MgAg alloy
25 cathode and transparent Indium-Tin-Oxide (ITO) deposited on a glass substrate as the anode. Egusa et al. in Japanese Journal of Applied Physics, Vol. 33, No. 5A, 1994, pp. 2741-2745 have shown that proper selection of the organic multilayer materials leads to energy barriers blocking both electrons and holes at the organic interface. This is illustrated in Figure 3 in

which electrons are blocked from entering the HTL 21 and holes from entering the ETL 20 by a clever choice of organic materials. This feature reduces quenching near the contacts (as illustrated in Figure 2) and also promotes a high density of electrons and holes in the small interface volume providing enhanced radiative recombination.

5

With multilayer device architectures now well understood and widely used, a remaining performance limitation of OLEDs is the electrodes. The main figure of merit for electrode materials is the position of the electrode Fermi energy relative to the relevant organic MO. In some applications it is also desirable for an electrode to be either transparent or highly
10 reflective to assist light extraction. Electrodes must also be chemically inert with respect to the adjacent organic material to provide long term OLED stability.

15

Much attention has been paid to the cathode, largely because good electron injectors are low work function metals which are also chemically reactive and oxidize quickly in atmosphere,
limiting the OLED reliability and lifetime. Much less attention has been paid to the
optimization of the anode contact, since conventional ITO anodes generally outperform the
cathode contact leading to an excess of holes. Due to this excess, and the convenience
associated with the transparency of ITO, improved anodes have not been as actively sought as
improved cathodes.

20

ITO is by no means an ideal anode, however. ITO is responsible for device degradation as a result of In diffusion into the OLED eventually causing short circuits as identified by G. Sauer et al., *Fresenius J. Anal. Chem.*, pp. 642-646, Vol. 353 (1995). ITO is polycrystalline and its abundance of grain boundaries provides ample pathways for contaminant diffusion into the
25 OLED. Finally, ITO is a reservoir of oxygen which is known to have a detrimental effect on many organic materials (see J.C. Scott, J.H. Kaufman, P.J. Brock, R. DiPietro, J. Salem, and J.A. Goita, *J. Appl. Phys.*, Vol. 79, p. 2745, 1996). Despite all of these problems, ITO anodes

are favored because no better transparent electrode material is known and ITO provides adequate stability for many applications.

5 While conventional OLEDs extract light through the ITO anode, architectures relying on light extraction through a highly transparent cathode (TC) are desirable for transparent OLEDs or OLEDs fabricated on an opaque substrate. Si is an especially desirable OLED substrate because circuits fabricated in the Si wafer can be cheaply integrated with drive circuitry providing display functions. Given the minaturization and outstanding performance of Si circuitry, a high information content OLED/Si display could be inexpensively fabricated on a Si
10 integrated circuit (IC).

The simplest approach incorporating a TC is to deposit a thin, semi-transparent low work function metal layer, e.g. Ca or MgAg, followed by ITO or another transparent, conducting material or materials, e.g. as reported in Bulovic et al., Nature, Vol. 380, No. 10, 1996 p. 29,
15 or in the co-pending PCT patent application PCT/IB96/00557, published on 11 December 1997 (publication number WO97/47050). To maximize the efficiency of such a TC OLED, a highly reflective anode which can direct more light out through the TC is desired. Consequently, the low reflectivity of ITO is a disadvantage in TC OLEDs.

20 Alternatively, for some applications it may be more important to increase the contrast ratio of the OLEDs or display based thereon. In this case, a TC OLED could benefit from a non-reflective, highly absorbing anode. Again the optical characteristics of ITO are a disadvantage.

25 High work function metals could form highly reflective anodes for TC OLEDs. Some of these metals, e.g. Au, have a larger work function than ITO (5.2 eV vs. 4.7 eV), but lifetime may be compromised because of high diffusivity in organic materials. Like In from ITO, only worse, Au diffuses easily through many organic materials and can eventually short circuit the device.

Efforts have been made to fabricate OLEDs on Si substrates (Parker and Kim, Applied Physics Letters, Vol. 64, No. 14, 1994, pp. 1774-1776). Si, due to its small bandgap and moderate work function, has a large barrier for both electron and hole injection into organic MOs, and therefore performs poorly as an electrode. Parker and Kim improved the situation somewhat by adding a SiO₂ interlayer between the Si and OLED. A voltage drop across the SiO₂ insulator permitted the Si bands to line up with their organic MO counterpart and electrons or holes from the Si to tunnel through the SiO₂ into the organic MO. However, the required voltage drop across the SiO₂ raised the OLED turn-on voltage >10 V, making these OLEDs inefficient. Low voltage OLED/Si designs are desirable not just to improve efficiency, but also to facilitate circuit design since sub-micron Si transistors cannot easily produce drive voltages >10 V. For anodes, more desirable than a tunneling insulator surface modification like SiO₂ is one which raises the Si surface work function thereby lowering the OLED operating voltage.

As can be seen from the above examples and description of the state of the art, electrode materials must be improved to realize OLEDs, and displays based thereon, with superior reliability and efficiency, and to enable novel architectures, such as devices emitting through a TC. In particular, to fabricate an OLED array or display on a Si substrate, an improved anode compatible with Si IC technology is required for optimized TC OLED architectures.

It is an object of the present invention to provide new and improved organic EL devices, arrays and displays based thereon.

It is a further purpose of the present invention to provide new and improved organic EL devices, arrays and displays based thereon optimized for light emission through a transparent cathode electrode with improved efficiency, lower operating voltage, or steeper current/voltage characteristic and increased reliability, stability and lifetime.

It is another object of the present invention to provide new and improved anodes for organic EL devices, arrays and displays fabricated on Si substrates.

5 It is a further object to provide a method for making the present new and improved organic EL devices, arrays and displays.

SUMMARY OF THE INVENTION

The above objects have been accomplished by providing an OLED having a cathode, an anode, and an organic region sandwiched in between, said anode being composed of

- 5 - a metal layer,
 - an anode modification layer, and
 - at least one barrier layer,

said anode being arranged such that said anode modification layer is in contact with said organic region and light is extracted through said cathode.

10

Any kind of metal is suited as metal layer in connection with the present invention. Examples are Al, Cu, Mo, Ti, Pt, Ir, Ni, Au, Ag, and any alloy thereof, or any metal stack such as Pt on Al and the like.

- 15 The inventive approach is specifically designed for the fabrication of OLEDs on top of Si, preferably Si crystalline wafers incorporating pre-processed integrated display circuitry (herein referred to as Si IC). The present invention is designed to modify the existing Si device metallization into a stable OLED anode having good hole injection properties. For OLEDs on top of a Si IC, the metal layer in the present invention is generally the final metallization layer
- 20 of the Si IC process, which consistent with present Si technology is normally Al, Cu or an alloy thereof. Neither Al, Cu or Al:Cu alloys perform well as OLED anodes, but they do provide excellent visible spectrum reflectivity which increases the amount of light extracted through a TC. The Si IC metallization surface can vary widely in terms of oxide thickness, roughness and surface contaminants depending on numerous factors, including the fabrication process, the
- 25 time between IC fabrication and OLED deposition, and the environment in which the Si IC was stored and shipped. For reproduceable fabrication of efficient OLEDs the Si metallization anode properties must be improved and effects arising from variations of the initial state of the metal surface must be eliminated.

The inventive approach is also suited for use with pixel and drive circuitry comprising polysilicon or amorphous silicon devices.

5 The anode modification layer in the present invention is mainly selected for its high work function which provides efficient hole injection into OLEDs. The anode modification layer must form a stable interface with the adjacent organic layer being part of the so-called organic region (e.g. the organic HTL) to insure consistent OLED performance over an extended time period. The anode modification layer can be conductive or insulating, but it should be sufficiently thin that it contributes negligibly both to the OLED series resistance and optical
10 absorption losses. Oxides are well suited as anode modification layers. The thickness of the anode modification layer is preferably between 0.5 nm and 10 nm.

The barrier layer or layers in the present invention isolates the anode modification layer from the metal layer by forming a physical and chemical barrier, while permitting charge to pass
15 freely through its interfaces with the metal layer and anode modification layer. The barrier layer(s) provides a consistent and reproduceable surface for the deposition or formation of the anode modification layer regardless of the metal layer composition or initial state of its surface. The barrier layer(s) can be conductive or insulating, but it (they) should be sufficiently thin that it (they) contributes negligibly to the OLED series resistance. Alternatively, the barrier layer(s)
20 can be highly reflective which avoids absorption losses. The thickness of the barrier layer is preferably between 5 nm-100 nm. Well suited are barrier layers comprising TiN or TiNC, for example.

For formation on a Si wafer, all of the layers comprising the anode must be depositable or
25 formable onto the wafer using processes sufficiently gentle that underlying Si circuitry is undamaged, i.e. at low temperature causing little chemical or physical damage.

In one embodiment of the present invention, a single or multilayer OLED structure having a TC fabricated on a Si substrate incorporates a multilayer anode structure comprising a metal layer, an anode modification layer, and an intermediate barrier layer(s), such that the anode is stable and efficient at hole injection.

5

The introduction of such an anode into the OLED structure leads to the following advantages:

Low voltage hole injection via both the high work function of the anode modification layer and the free passage of charge from the metal layer, through the barrier layer(s) into the anode modification layer.

10

Stable OLED operation over an extended time period via the chemical and physical barrier the barrier layer(s) provides between the metal layer and anode modification layer, and the stability of the anode modification layer interface with the adjacent organic HTL.

15

Efficient light extraction through the TC aided by the high reflectivity and low absorption of the metal layer, barrier layer(s) and anode modification layer stack.

DESCRIPTION OF THE DRAWINGS

The invention is described in detail below with reference to the following schematic drawings.

It is to be noted that the Figures are not drawn to scale.

- 5 FIG. 1A shows the band structure of a known OLED having an emission layer and two electrodes (Prior Art).
- 10 FIG. 1B shows the band structure of another known OLED having an emission layer and two metal electrodes, with work functions chosen such that the energy barrier for carrier injection is reduced (Prior Art).
- 15 FIG. 2 shows the band structure of another known OLED having an emission layer and two metal electrodes, the work function of the anode being chosen such that the energy barrier for hole injection is low, whereas the work function of the cathode poorly matches the emission layer yielding little electron injection and little radiative recombination in said emission layer (Prior Art).
- 20 FIG. 3 shows the band structure of another known OLED having an electron transport layer and hole transport layer (Prior Art).
- 25 FIG. 4 is a schematic cross section of a first embodiment of the present invention.
- FIG. 5 is a schematic cross section of a second embodiment of the present invention.
- FIG. 6 is a schematic cross section of a third embodiment of the present invention.

DESCRIPTION OF PREFERRED EMBODIMENTS:

A first improved structure benefiting from the inventive anode approach is illustrated and discussed in connection with Figure 4.

To provide high performance TC OLED devices fabricated on Si substrates, improved structures benefiting from the inventive anode approach, as illustrated in Figures 4-6, are provided, enabling new array and display applications. Three embodiments of improved OLEDs incorporating the inventive anodes are detailed in connection with Figures 4-6.

A first embodiment is depicted in Figure 4. A TC OLED is shown which is formed on a substrate 45. Since in the present configuration the electroluminescent light 52 is emitted through the top electrode (cathode 51), almost any kind of substrate 45 can be used. Examples are Si, glass, quartz, stainless steel, and various plastics. The inventive anode, comprising a metal layer 46, a barrier layer 47, and an anode modification layer 48 is situated on said substrate 45. Any kind of metal is suited as metal layer 46. Examples are Al, Cu, Mo, Ti, Pt, Ir, Ni, Au, Ag, and any alloy thereof, or any metal stack such as Pt on Al and the like. Depending on the embodiment, particularly well suited are metals which provide visible spectrum reflectivity.

The barrier layer 47 isolates the anode modification layer 48 from the metal layer 46 by forming a physical and chemical barrier, while permitting charge to pass freely through its interfaces with the metal layer 46 and anode modification layer 48. Note that the inventive anode might comprise one or more barrier layers. The barrier layer(s) 47 provides a consistent and reproduceable surface for the formation or deposition of the anode modification layer 48 regardless of the metal layer composition or initial state of its surface. The barrier layer(s) 47 can be conductive or insulating, but it (they) should be sufficiently thin that it (they) contributes negligibly to the OLED series resistance. Alternatively, the barrier layer(s) 47 can

be reflective which avoids absorption losses. The thickness of the barrier layer is preferably between 5 nm-100 nm.

The anode modification layer 48 is mainly selected for its high work function which provides efficient hole injection into the organic region of the OLED. The anode modification layer 48 must form a stable interface with the adjacent organic emission layer (EML) 49 to insure consistent OLED performance over an extended time period. The anode modification layer 48 can be conductive or insulating, but it must be sufficiently thin that it contributes negligibly to both the OLED series resistance and the optical absorption losses. The thickness of the anode modification layer is preferably between 0.5 nm and 10 nm.

A TC 51 is situated on the EML 49. The electroluminescence takes place within the EML 49. As indicated in Figure 4, part of the light is emitted directly through the EML 49 and the TC 51 into the half space above the OLED. Another part of the light travels towards the inventive anode structure. The anode structure reflects the light such that it is also emitted into the half space above the OLED.

Table 1: Exemplary details of the first embodiment

Layer	No.	Material	Thickness	present example
Substrate	45	Quartz	0.05 - 5 mm	800 μ m
Metal Layer	46	Ti/Al	0.01-0.7 μ m / 0.05-3 μ m	2 nm
Barrier Layer	47	Ni	0.01 - 2 μ m	30 nm
Anode modification Layer	48	ITO	0.003 - 2 μ m	7 nm
Emission Layer	49	PPV	50 - 500 nm	200 nm
Transparent Cathode	51	Li:Al alloy	50 - 1000 nm	120 nm

A second embodiment of the inventive anode for TC OLEDs fabricated on Si substrates is depicted in Figure 5. From the substrate 25 up, listed in the order of deposition, is a Si IC/InN/InNO₃/HTL/ETL/TC OLED structure. The Si IC 25 in Figure 5 comprises an Al top metal contact pad 26 which also serves as the metal layer in the inventive anode. After

completion of the Si IC fabrication, an InN barrier layer 27 is deposited directly onto the substrate such that it overlaps at least the contact pad 26. The sample is then oxidized in an oxygen plasma, or equivalently in an air, steam, ozone or other oxidizing environment to prepare an InNO_x surface anode modification layer 28 capable of low voltage hole injection
5 into the organic HTL 29. Electrons injected into the ETL 30 from the TC 31 recombine with the holes in the organic region producing EL 32 which is extracted through the TC 31. The organic region in the present embodiment comprises an HTL 29 and an ETL 30. It is to be noted that the organic region in any case at least comprises one organic layer (see first embodiment, for example). The Si IC 25 might comprise integrated circuitry which is not
10 illustrated in Figure 5, for sake of simplicity. Instead of InN other group III nitrides might be used, for example.

InN is an excellent barrier layer material because it is a degenerate semiconductor which has both excellent transparency and is conductive, but not so conductive that lateral conduction
15 through the InN barrier layer 27 between adjacent Al metal pads 26 on the Si IC 25 causes electrical crosstalk. InN having these properties can be deposited at or near room temperature as described in Beierlein et al., Materials Research Society Internet Journal of Nitride Semiconductor Research, Vol. 2, Paper 29. InN is also a convenient choice because its surface work function can be increased by oxidation thus forming an InNO_x anode modification layer
20 28 directly on the InN barrier layer. Equivalently, the InNO_x anode modification layer 28 could be directly deposited onto the InN.

Several methods of deposition of oxide-based anode modification layers are listed below:

- 25
- chemical vapor deposition (CVD), including plasma-enhanced chemical vapor deposition (PECVD);
 - sputter deposition or reactive (e.g. in an oxygen environment) sputter deposition;
 - thermal evaporation;
 - electron-beam evaporation;

30

 - oxygen plasma (plasma-assisted oxidation);
 - thermal annealing in an oxidizing environment;

- UV-ozone treatment;
- wet-chemical oxidation;
- electrochemical oxidation;
- spin-coating from solution.

5

A completely different anode modification layer 28 could also be substituted, e.g. ITO, ZnO, MgO, Sn₂O₃, In₂O₃, RuO₂, or V₂O₅, or similar oxides, just to give some examples. Similarly, a completely different metal layer 26 could also be substituted. The degeneracy of the InN semiconductor insures that charge can pass easily from the metal layer 26 into the InN barrier layer 27, regardless of the composition or initial state of the metal layer 26 surface. For the same reason, charge can also traverse the InN barrier layer 27 and into the anode modification layer 28 without significant series resistance. The strength of the highly polar In-N bond insures that InN 27 acts as an excellent chemical and physical barrier to corrosion or diffusion between the metal layer 26 and the anode modification layer 28.

15

The device depicted in Figure 5 benefits from the high reflectivity of the Al metal layer 26, and the low visible spectrum absorption of the InN barrier layer 27 and the InNO_x anode modification layer 28, which permits much of the EL 32 emitted towards the substrate to be reflected back through the TC 31.

20

Devices having the anode structure depicted in Figure 5 exhibit higher quantum and power efficiencies than comparable structures having conventional ITO anodes as a result of more balanced charge injection between the Al/InN/InNO_x anode and the TC.

Table 2: Exemplary details of the second embodiment

Layer	No.	Material	Thickness	present example
Substrate	25	Si IC	0.05 - 1 mm	500 μ m
Metal Layer	26	Aluminum	0.05 - 2 μ m	500 nm
Barrier Layer	27	InN	0.01 - 1 μ m	20 nm
Anode modification Layer	28	InNO _x	0.001 - 1 μ m	5 nm
Hole Transport Layer	29	TAD	10 - 200 nm	50 nm
Electron Transport Layer	30	Alq ₃	10 - 200 nm	50 nm
Transparent Cathode	31	MgAg/ITO	1-20 nm / 10-1000 nm	80 nm / 50 nm

A third embodiment of the inventive anode for TC OLEDs fabricated on Si substrates is depicted in Figure 6. From the substrate 33 up, listed in the order of deposition, is a Si IC/Ni/NiO_x/V₂O₅/HTL/EML/ETL/TC OLED structure. The Si IC 33 in Figure 6 comprises an Al:Cu alloy top metal contact 34 which serves as the metal layer in the inventive anode. After completion of the Si IC, a two layer Ni 35/NiO_x 36 barrier layer is deposited in sequence directly onto those parts of the substrate 33 which are covered by the metal contact layer 34, or alternatively, the Ni 35 barrier layer is deposited, and its surface is subsequently oxidized to form the NiO_x 36 barrier layer. The inventive anode is completed by the deposition of the V₂O₅ anode modification layer 37 capable of injecting holes into the HTL 38. Electrons injected into the ETL 40 from the TC 41 recombine in the organic emission layer 39 producing EL 42 which is extracted through the TC 41. The circuitry in the Si substrate is not shown for simplicity.

We note that an arbitrarily large number of barrier layers 35, 36 can be inserted between the metal layer 34 and the anode modification layer 37 of the inventive anode provided that they do not reduce device efficiency through excessive series resistance at their interfaces or in their bulk. The Ni 35/NiO_x 36 barrier layer structure of the present embodiment relies on the high reflectivity of the Ni 35 metal and the transparency and thinness of the insulating NiO_x 36 layer to insure good device efficiency.

We note that the third embodiment without the Ni and NiO_x layers is unstable due to a chemical reaction between the Al:Cu alloy 34 and the anode modification layer 37. The oxidation of the Ni 35 surface, or alternatively the deposition of an additional barrier layer further chemically isolates the Ni metal from the anode modification layer 37. Because the Ni 35 barrier layer is highly conductive, it must be very thin, or patterned (as shown in Figure 6) to avoid lateral conduction between adjacent IC metallizations 34 (not shown in Figure 6).

Devices having the inventive metal/Ni/NiO_x/V₂O₅ anode structure depicted in Figure 6 exhibit steeper current/voltage characteristics than conventional ITO anodes and similar power efficiencies.

Table 3: Exemplary details of the third embodiment

Layer	No.	Material	Thickness	present example
Substrate	33	Si IC	0.05 - 5 mm	500 μm
Metal Layer	34	Al-Cu	0.05 - 5 μm	500 nm
Barrier Layer	35	Ni	0.1 - 1000 nm	2.5 nm
Barrier Layer	36	NiO _x	0.1 - 10 nm	1 nm
Anode modification layer	37	V ₂ O ₅	0 - 1 μm	5 nm
Hole Transport Layer	38	NPB	10 - 200 nm	50 nm
Emission Layer	39	Alq ₃ :Rubrene	1 - 100 nm	15 nm
Electron Transport Layer	40	Alq ₃	10 - 200 nm	50 nm
Transparent Cathode	41	Ca/InGa _N /ITO	1-20 nm / 10-100 nm / 10-1000nm	10 nm / 80 nm / 150nm

In the following, some display embodiments, based on and enabled by the present invention, are addressed.

Any of the three embodiments, or modifications thereof, can be part of a display or array. The Si substrate, for example, might comprise integrated circuitry which drives the pixels of the OLEDs formed thereon. For this purpose, the inventive anode might be connected to the metal contact of an active matrix element formed in the Si IC substrate. If the circuitry is patterned appropriately, individual pixels or groups of pixels can be turned on and off.

Arrays and displays can be realized with high quantum and power efficiencies, lower threshold voltages, and/or steep current/voltage characteristics. The inventive anode is compatible with many known approaches.

5

It is advantageous to integrate OLEDs onto Si substrates because prior to OLED deposition, the substrate can be fabricated to contain the active Si devices, such as for example an active matrix, drivers, memory and so forth. Such an OLED on Si structure can be a very inexpensive small area organic display with high resolution and performance. An OLED or OLED array may either be grown directly on such a Si substrate carrying Si devices, or it may be fabricated separately and assembled in a flip-chip fashion onto the Si circuitry later.

10

One problem is that the Si metallization is typically Al or an Al alloy which are poor OLED anode or cathode materials. The inventive anode permits a stable, low voltage hole contact to be formed on top of the standard Si process metallizations.

15

In the following some examples of the different organic materials which can be used are given.

Electron transport/Emitting materials:

Alq₃, Gaq₃, Inq₃, Scq₃, (q refers to 8-hydroxyquinolate or it's derivatives) and other 8-hydroxyquinoline metal complexes such as Znq₂, Beq₂, Mgq₂, ZnMq₂, BeMq₂, BAlq, and AlPrq₃, for example. These materials can be used as the ETL or emission layer.

20

Other classes of electron transporting materials are electron-deficient nitrogen-containing systems, for example oxadiazoles like PBD (and many derivatives), and triazoles, for example TAZ (1,2,4-triazole).

These functional groups can also be incorporated in polymers, starburst and spiro compounds. Further classes are materials containing pyridine, pyrimidine, pyrazine and pyridazine functionalities.

Finally, materials containing quinoline, quinoxaline, cinnoline, phthalazine and quinazoline functionalities are well known for their electron transport capabilities.

Other materials are didecyl sexithiophene (DPS6T), bis-triisopropylsilyl sexithiophene (2D6T), azomethin-zinc complexes, pyrazine (e.g. BNVP), styrylanthracene derivatives (e.g. BSA-1, BSA-2), non-planar distyrylarylene derivatives, for example DPVBi (see C. Hosokawa and T. Kusumoto, International Symposium on Inorganic and Organic Electroluminescence 1994, Hamamatsu, 42), cyano-substituted polymers such as cyano-PPV (PPV means poly(p-phenylenevinylene)) and cyano-PPV derivatives.

The following materials are particularly well suited as

Emission layers and Dopants:

Anthracene, pyridine derivatives (e.g. ATP), Azomethin-zinc complexes, pyrazine (e.g. BNVP), styrylanthracene derivatives (e.g. BSA-1, BSA-2), Coronene, Coumarin, DCM compounds (DCM1, DCM2), distyryl arylene derivatives (DSA), alkyl-substituted distyrylbenzene derivatives (DSB), benzimidazole derivatives (e.g. NBI), naphthostyrylamine derivatives (e.g. NSD), oxadiazole derivatives (e.g. OXD, OXD-1, OXD-7), N,N,N',N'-tetrakis(m-methylphenyl)-1,3-diaminobenzene (PDA), perylene and perylene derivatives, phenyl-substituted cyclopentadiene derivatives, 12-phthaloperinone sexithiophene (6T), polythiophenes, quinacridones (QA) (see T. Wakimoto et al., International Symposium on Inorganic and Organic Electroluminescence, 1994, Hamamatsu, 77), and substituted quinacridones (MQA), rubrene, DCJT (see for example: C. Tang, SID Conference San Diego; Proceedings, 1996, 181), conjugated and non-conjugated polymers, for example PPV and PPV derivatives, dialkoxy and dialkyl PPV derivatives, for example

MEH-PPV (poly(2-methoxy)-5-(2'-ethylhexoxy)-1,4-phenylene-vinylene),
poly(2,4-bis(cholestanoxyl)-1,4-phenylene-vinylene) (BCHA-PPV), and segmented PPVs (see
for example: E. Staring in International Symposium on Inorganic and Organic
Electroluminescence, 1994, Hamamatsu, 48, and T. Oshino et al. in Sumitomo Chemicals,
5 1995 monthly report).

Hole transport layers and Hole injection layers:

The following materials are suited as hole injection layers and hole transport layers. Materials
containing aromatic amino groups, like tetraphenyldiaminodiphenyl (TPD-1, TPD-2, or TAD)
and NPB (see C. Tang, SID Meeting San Diego, 1996, and C. Adachi et al. Applied Physics
10 Letters, Vol. 66, p. 2679, 1995), TPA, NIPC, TPM, DEH (for the abbreviations see for
example: P. Borsenberger and D.S. Weiss, Organic Photoreceptors for Imaging Systems,
Marcel Dekker, 1993). These aromatic amino groups can also be incorporated in polymers,
starburst (for example: TCTA, m-MTDATA, see Y. Kuwabara et al., Advanced Materials, 6,
p. 677, 1994, Y. Shirota et al., Applied Physics Letters, Vol. 65, p. 807, 1994) and spiro
15 compounds.

Further examples are: Copper(II) phthalocyanine (CuPc),
(N,N'-diphenyl-N,N'-bis-(4-phenylphenyl)-1,1'-biphenyl-4,4'-diamine), distyryl arylene
derivatives (DSA), naphthalene, naphthostyrylamine derivatives (e.g. NSD), quinacridone
(QA), poly(3-methylthiophene) (P3MT) and its derivatives, perylene and perylene derivatives,
20 polythiophene (PT), 3,4,9,10-perylenetetracarboxylic dianhydride (PTCDA), PPV and some
PPV derivatives, for example MEH-PPV, poly(9-vinylcarbazole) (PVK), discotic liquid
crystal materials (HPT).

There are many other organic materials known as being good light emitters, charge transport
materials, and charge injection materials, and many more will be discovered. These materials
25 can be used as well for making light emitting structures according to the present invention.
More information on organic materials can be found in text books and other well known

publications, such as the book "Inorganic and Organic Electroluminescence", edited by R.H. Mauch et al., Wissenschaft und Technik Verlag, Berlin, Germany, 1996, and the book "1996 SID International Symposium, Digest of Technical Papers", first edition, Vol. XXVII, May 1996, published by Society for Information Display, 1526 Brookhollow Dr., Suite 82, Santa Ana, CA, USA.

Additionally, blend (i.e. guest-host) systems containing active groups in a polymeric binder are also possible. The concepts employed in the design of organic materials for OLED applications are to a large extent derived from the extensive existing experience in organic photoreceptors. A brief overview of some organic materials used in the fabrication of organic photoreceptors is found in the above mentioned publication of P. Brosenberger and D.S. Weiss, and in Teltech, Technology Dossier Service, Organic Electroluminescence (1995), as well as in the primary literature.

OLEDs have been demonstrated using polymeric, oligomeric and small organic molecules. The devices formed from each type of molecule are similar in function, although the deposition of the layers varies widely. The present invention is equally valid in all forms described above for organic light emitting devices based on polymers, oligomers, or small molecules.

Small molecule devices are routinely made by vacuum evaporation. This is compatible with the process used for the formation of the inventive anode.

Evaporation can be performed in a Bell jar type chamber with independently controlled resistive and electron-beam heating of sources. It can also be performed in a molecular beam deposition system incorporating multiple effusion cells and sputter sources. Oligomeric and polymeric organics can also be deposited by evaporation of their monomeric components with later polymerization via heating or plasma excitation at the substrate. It is therefore possible to copolymerize or create mixtures by co-evaporation.

In general, polymer containing devices (single layer, multilayer, polymer blend systems, etc.) are made by dissolving the polymer in a solvent and spreading it over the substrate either by spin coating or the doctor blade technique. After coating the substrate, the solvent is removed by evaporation or otherwise. This method allows the fabrication of well defined multilayer organic stacks, provided that the respective solvents for each subsequent layer do not dissolve previously deposited layers.

Additionally, hybrid devices containing both polymeric and evaporated small organic molecules are possible. In this case, the polymer film is generally deposited first, since evaporated small molecule layers often cannot withstand much solvent processing.

CLAIMS

1. An organic electroluminescent device comprising an anode, a cathode, and an organic region being sandwiched in between, characterized in that the anode comprises
 - a metal layer,
 - a barrier layer, and
 - an anode modification layer,wherein said anode is arranged such that said anode modification layer is in contact with said organic stack and light is emitted through said cathode.
2. The device of claim 1, wherein the surface of the barrier layer is oxidized to form the anode modification layer.
3. The device of claim 1, wherein the anode modification layer is deposited onto the barrier layer.
4. The device of claim 1, wherein the barrier layer comprises a group III nitride, such as InN.
5. The device of claim 1, wherein the metal layer comprises Al or Cu.
6. The device of claim 1, wherein the anode modification layer has a high workfunction.
7. The device of claim 1, wherein the metal layer comprises metal which provides visible spectrum reflectivity to increase the amount of light extracted through said cathode.
8. The device of claim 1, wherein the anode modification layer and/or the barrier layer strongly absorb visible light.

9. The device of claim 1, wherein the metal layer comprises Al, Cu, Mo, Ti, Pt, Ir, Ni, Au, or Ag, or any alloy thereof, or any metal stack such as Pt on Al.

10. The device of claim 1, wherein the metal layer is formed on a substrate.

5

11. The device of claim 10, wherein the substrate is a silicon substrate.

12. The device of claim 11, wherein the silicon substrate is crystalline.

10 13. The device of claim 10, wherein the substrate comprises polysilicon circuitry or amorphous circuitry.

14. The device of claim 11, wherein the silicon substrate comprises integrated circuitry.

15 15. The device of claim 1, wherein the anode modification layer is selected to provide efficient hole injection into the organic region.

16. The device of claim 1, wherein the anode modification layer is selected to form a stable interface with the organic region.

20

17. The device of claim 1, wherein the anode modification layer is conductive or insulating.

18. The device of claim 1, wherein an oxide layer serves as anode modification layer.

25 19. The device of claim 1, wherein the barrier layer physically and chemically isolates the anode modification layer from the metal layer by forming a barrier, while permitting charge to pass through its interfaces with the metal layer and anode modification layer.

20. The device of claim 1, wherein the barrier layer is conductive or insulating.

21. The device of claim 1, wherein the barrier layer is highly reflective.

5 22. The device of claim 1, wherein the anode modification layer comprises ITO, ZnO, MgO, Sn₂O₃, In₂O₃, RuO₂, or V₂O₅.

23. The device of claim 1, wherein the barrier layer comprises a Ni layer and a NiO_x layer, and the anode modification layer comprises V₂O₅.

10

24. Display or array comprising at least one device according to claim 1 said device being formed on a substrate.

25. Display of claim 24, wherein said substrate is a silicon substrate.

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26. Display of claim 25, wherein circuitry is integrated into the substrate.

27. Display of claim 26, wherein the circuitry is designed to drive the device.

20 28. Display of claim 24, wherein said anode is patterned.

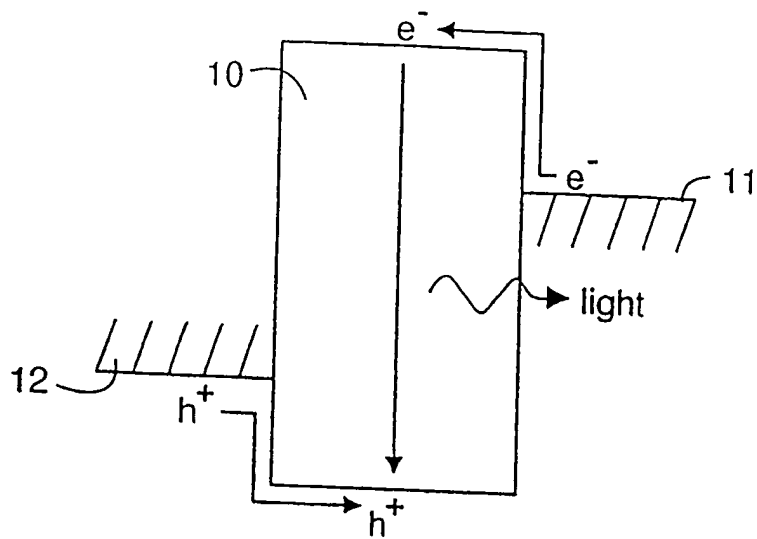
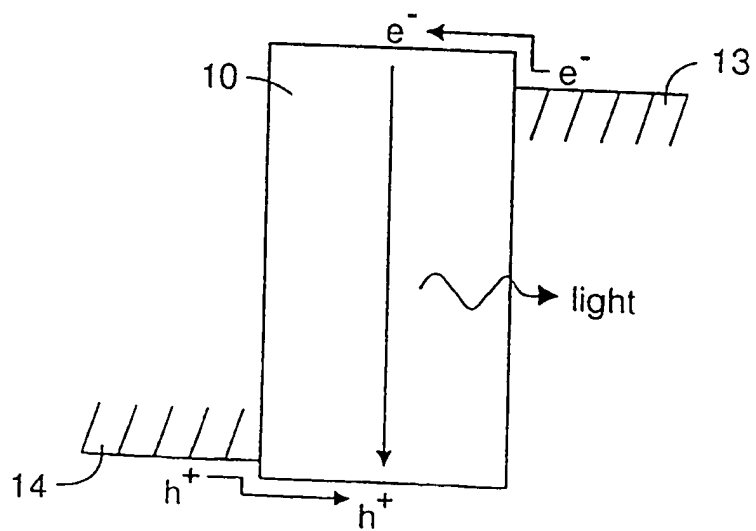
29. Method for making an organic electroluminescent device comprising an anode, a cathode, and an organic region being sandwiched in between, said method comprising the steps:

- building up said anode prior to the formation of said organic region and cathode, by
25 forming a metal layer, a barrier layer situated on the metal layer, and an anode modification layer situated on the barrier layer,

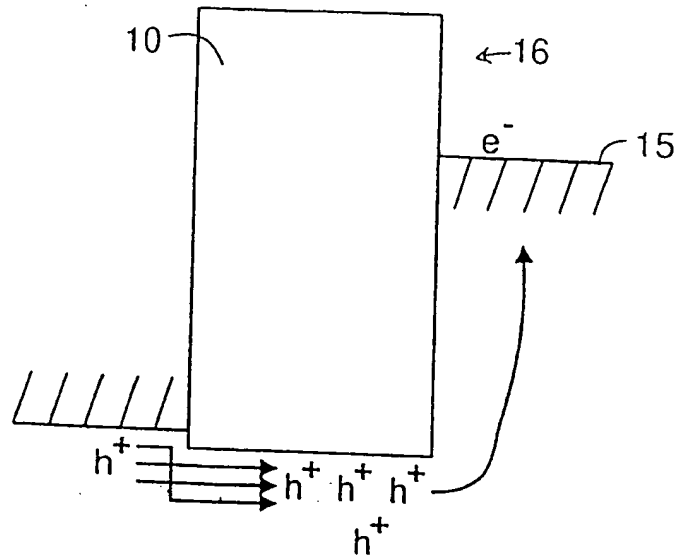
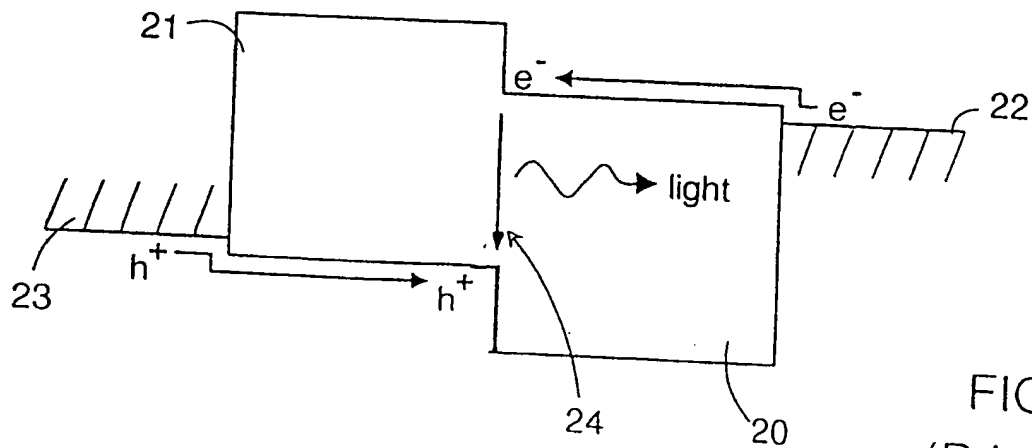
said anode being arranged such that said anode modification layer is in contact with said organic stack and light is emitted through said cathode.

30. The method of claim 29, wherein an oxide serves as said anode modification layer, said oxide being formed by oxidizing the surface of the barrier layer.
- 5 31. The method of claim 29, wherein the anode modification layer is formed by depositing it onto the barrier layer.

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FIG. 1A
(Prior Art)FIG. 1B
(Prior Art)

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FIG. 2
(Prior Art)FIG. 3
(Prior Art)

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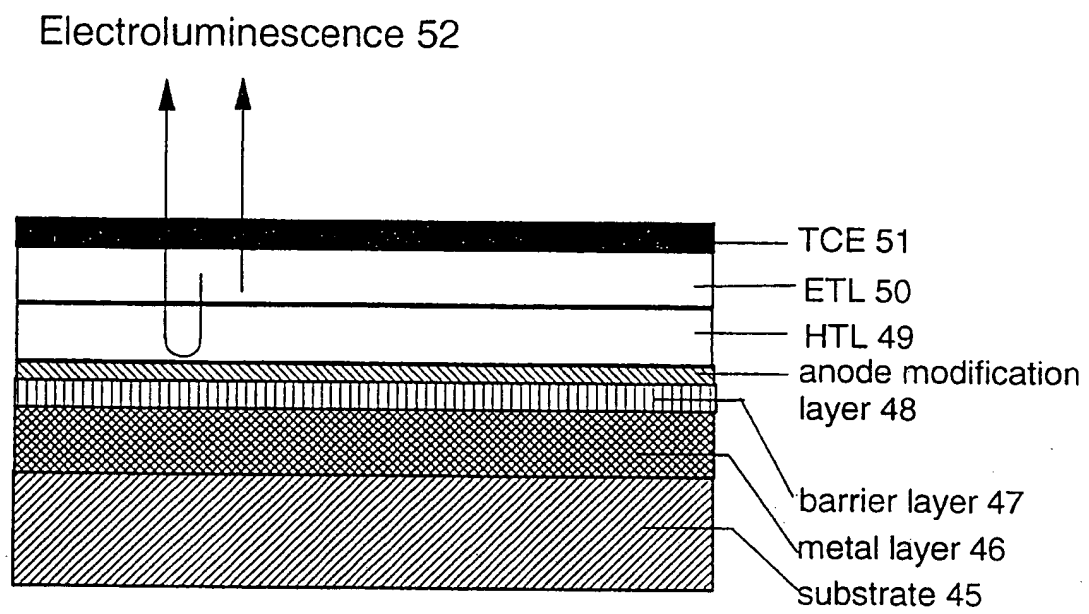


FIG. 4

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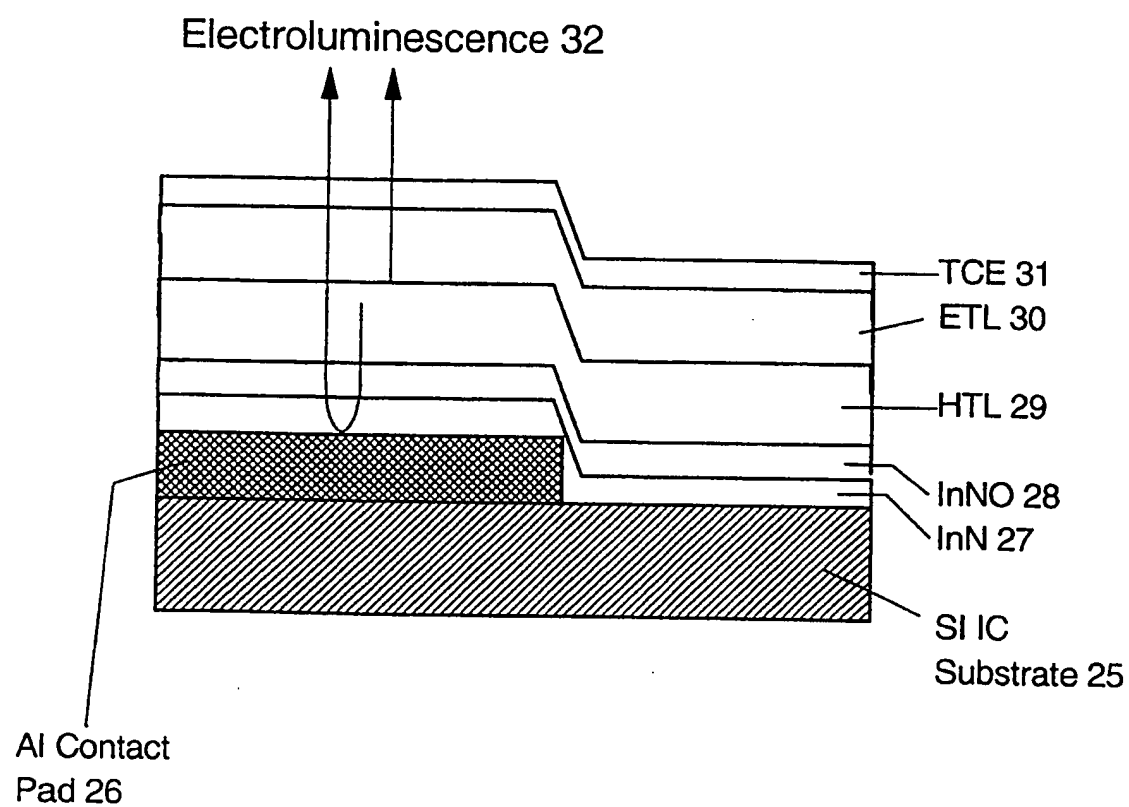


FIG. 5

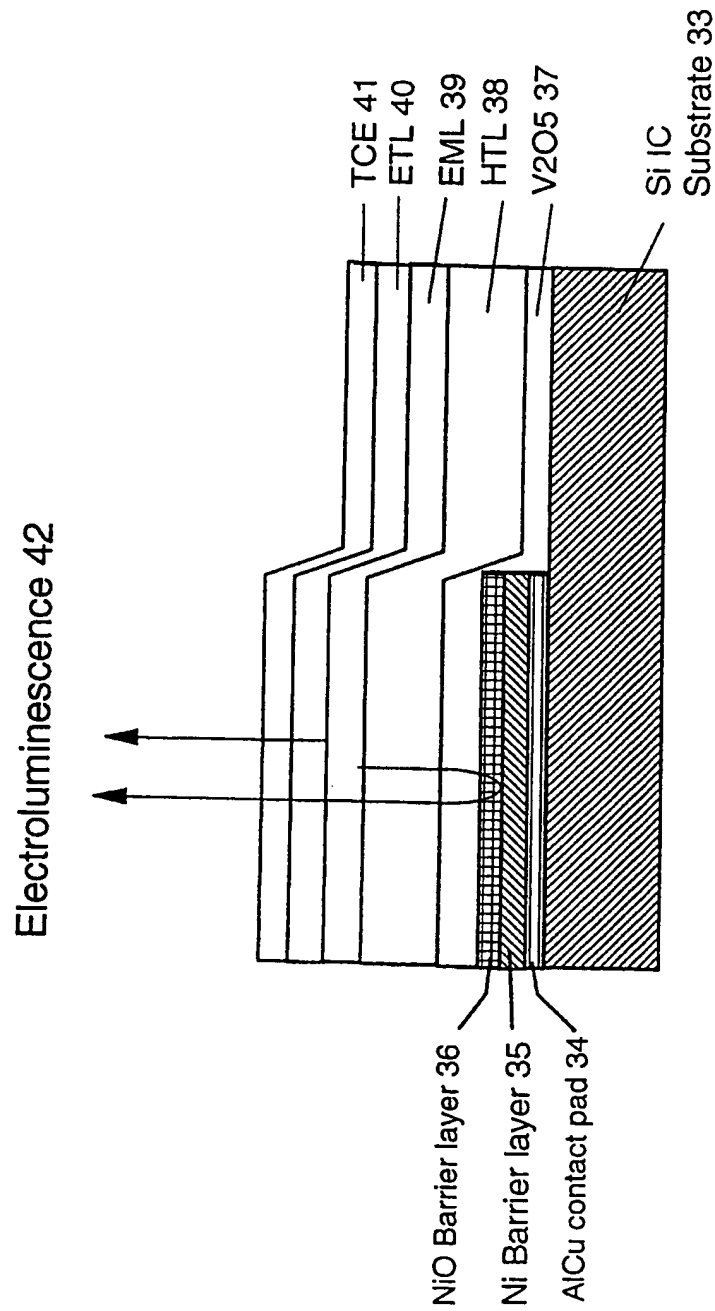


FIG. 6

INTERNATIONAL SEARCH REPORT

Internal Application No
PCT/IB 98/00124

A. CLASSIFICATION OF SUBJECT MATTER
IPC 6 H01L51/20

According to International Patent Classification(IPC) or to both national classification and IPC

B. FIELDS SEARCHED

Minimum documentation searched (classification system followed by classification symbols)
IPC 6 H01L H05B

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

Electronic data base consulted during the international search (name of data base and, where practical, search terms used)

C. DOCUMENTS CONSIDERED TO BE RELEVANT

Category *	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
A	WO 97 47051 A (STRITE SAMUEL CLAGETT ;IBM (US); TANG CHING WAN (US); EASTMAN KODA) 11 December 1997 see page 21, line 1-8 -----	1, 29
A	EP 0 668 620 A (AT & T CORP) 23 August 1995 see abstract -----	1, 29

☐ Further documents are listed in the continuation of box C.

☒ Patent family members are listed in annex.

* Special categories of cited documents :

"A" document defining the general state of the art which is not considered to be of particular relevance

"E" earlier document but published on or after the international filing date

"L" document which may throw doubts on priority claim(s) or which is cited to establish the publication date of another citation or other special reason (as specified)

"O" document referring to an oral disclosure, use, exhibition or other means

"P" document published prior to the international filing date but later than the priority date claimed

"T" later document published after the international filing date or priority date and not in conflict with the application but cited to understand the principle or theory underlying the invention

"X" document of particular relevance; the claimed invention cannot be considered novel or cannot be considered to involve an inventive step when the document is taken alone

"Y" document of particular relevance; the claimed invention cannot be considered to involve an inventive step when the document is combined with one or more other such documents, such combination being obvious to a person skilled in the art.

"&" document member of the same patent family

Date of the actual completion of the international search

7 October 1998

Date of mailing of the international search report

16/10/1998

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De Laere, A

INTERNATIONAL SEARCH REPORT

Information on patent family members

International Application No

PCT/IB 98/00124

Patent document cited in search report	Publication date	Patent family member(s)	Publication date
WO 9747051 A	11-12-1997	WO 9747050 A	11-12-1997
EP 0668620 A	23-08-1995	US 5619058 A	08-04-1997
		JP 7263742 A	13-10-1995